SLOS338D – SEPTEMBER 2000 – REVISED DECEMBER 2002

- $\bullet$  **Modulation Scheme Optimized to Operate Without a Filter**
- $\bullet$ **TSSOP Package Options**
- $\bullet$ **1 W Into an 8-**Ω **Speaker (THD+N**<**1%)**
- $\bullet$  <**0.2% THD+N at 1 W, 1 kHz, Into an 8-**Ω **Load**
- $\bullet$  **Extremely Efficient Third Generation 5-V Class-D Technology:**
	- **Low-Supply Current (No Filter) . . . 4 mA**
	- **Low-Supply Current (Filter) . . . 7.5 mA**
	- **Low-Shutdown Current . . . 0.05** µ**A**
	- **Low-Noise Floor . . . 40** µ**VRMS (No-Weighting Filter)**
	- **Maximum Efficiency Into 8** Ω**, 75 85%**
	- **4 Internal Gain Settings . . . 6 23.5 dB**
	- **PSRR . . . –77 dB**
- **Integrated Depop Circuitry**
- $\bullet$  **Short-Circuit Protection (Short to Battery, Ground, and Load)**

#### **description**

The TPA2001D1 is a 1-W mono bridge-tied-load (BTL) class-D amplifier designed to drive a speaker with at least 8-Ω impedance. The amplifier uses TI's third generation modulation technique, which results in improved efficiency and SNR. It also allows the device to be connected directly to the speaker without the use of the LC output filter commonly associated with class-D amplifiers (this results in EMI which must be shielded at the system level). These features make the device ideal for use in devices where high-efficiency is needed to extend battery run time.

The gain of the amplifier is controlled by two input terminals, GAIN1, and GAIN0. This allows the amplifier to be configured for a gain of 6, 12, 18, and 23.5 dB. The differential input terminals are high-impedance CMOS inputs, and can be used as summing nodes.

The class-D BTL amplifier includes depop circuitry to reduce the amount of turnon pop at power up, and when cycling SHUTDOWN.

The TPA2001D1 is available in the 16-pin TSSOP package that drives 1 W of continuous output power into an 8-Ω load. TPA2001D1 operates over an ambient temperature range of  $-40^{\circ}$ C to 85°C.



**AVAILABLE OPTIONS**

† The PW package is available taped and reeled. To order a taped and reeled part, add the suffix R to the part number (e.g., TPA2001D1PWR).



Please be aware that an important notice concerning availability, standard warranty, and use in critical applications of Texas Instruments semiconductor products and disclaimers thereto appears at the end of this data sheet.

**PRODUCTION DATA information is current as of publication date. Products conform to specifications per the terms of Texas Instruments standard warranty. Production processing does not necessarily include testing of all parameters.**



Copyright © 2002, Texas Instruments Incorporated



SLOS338D – SEPTEMBER 2000 – REVISED DECEMBER 2002



#### **TERMINAL NAME NO. I/O DESCRIPTION GQC PW** AGND  $A3 - A5$ B2 – B6  $C2 - C6$ D2 – D4 15 | | | | Analog ground BYPASS **After Affect** 16 | I Connect capacitor to ground for BYPASS voltage filtering. COSC B7 | 14 | I Connect capacitor to ground to set oscillation frequency. GAIN0 **C1** C<sub>1</sub> 4 | I Bit 0 of gain control (TTL logic level) GAIN1 | D1 | 5 | I | Bit 1 of gain control (TTL logic level) INN A1 2 I Negative differential input INP A2 1 I Positive differential input OUTN G7 10 O Negative BTL output OUTP G1 7 O Positive BTL output PGND D5, D6  $E2 - E6$ F2 – F6 G2 – G6 8, 9 I High-current grounds  $PV<sub>DD</sub>$  E1, E7,<br>F1, F7 6, 11 | I | High-current power supplies ROSC **C7** 13 | Connect resistor to ground to set oscillation frequency. SHUTDOWN B1 3 | Blaces the amplifier in shutdown mode if a TTL logic low is placed on this terminal, and normal operation if a TTL logic high is placed on this terminal. V<sub>DD</sub>  $\vert$  D7 | 12 | | Analog power supply



SLOS338D – SEPTEMBER 2000 – REVISED DECEMBER 2002

#### **absolute maximum ratings over operating free-air temperature range (unless otherwise noted)†**



† Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

#### **DISSIPATION RATING TABLE**



### **recommended operating conditions**



### electrical characteristics at specified free-air temperature, PV<sub>DD</sub> = 5 V, T<sub>A</sub> = 25°C (unless **otherwise noted)**



## **operating characteristics, PV<sub>DD</sub> = 5 V, T<sub>A</sub> = 25°C, R<sub>L</sub> = 8 Ω, gain = 6 dB (unless otherwise noted)**





### electrical characteristics at specified free-air temperature, PV<sub>DD</sub> = 3.3 V, T<sub>A</sub> = 25°C (unless **otherwise noted)**



## **operating characteristics, PV<sub>DD</sub> = 3.3 V, T<sub>A</sub> = 25°C, R<sub>L</sub> = 8**  $\Omega$ **, gain = 6 dB (unless otherwise noted)**





## **APPLICATION INFORMATION**

## **eliminating the output filter with the TPA2001D1**

This section focuses on why the user can eliminate the output filter with the TPA2001D1.

#### **effect on audio**

The class-D amplifier outputs a pulse-width modulated (PWM) square wave, which is the sum of the switching waveform and the amplified input audio signal. The human ear acts as a band-pass filter such that only the frequencies between approximately 20 Hz and 20 kHz are passed. The switching frequency components are much greater than 20 kHz, so the only signal heard is the amplified input audio signal.

#### **traditional class-D modulation scheme**

The traditional class-D modulation scheme, which is used in the TPA005Dxx family, has a differential output where each output is 180 degrees out of phase and changes from ground to the supply voltage ( $V_{DD}$ ). Therefore, the differential prefiltered output varies between positive and negative  $V_{DD}$ , where filtered 50% duty cycle yields 0 volts across the load. The traditional class-D modulation scheme with voltage and current waveforms is shown in Figure 1. Note that even at an average of 0 V across the load (50% duty cycle), the current to the load is high, causing high loss, thus causing a high supply current.



**Figure 1. Traditional Class-D Modulation Scheme's Output Voltage and Current Waveforms Into an Inductive Load With No Input**

### **TPA2001D1 modulation scheme**

The TPA2001D1 uses a modulation scheme that still has each output switching from 0 to the supply voltage. However, OUTP and OUTN are now in phase with each other with no input. The duty cycle of OUTP is greater than 50% and OUTN is less than 50% for positive voltages. The duty cycle of OUTP is less than 50% and OUTN is greater than 50% for negative voltages. The voltage across the load sits at 0 V throughout most of the switching period greatly reducing the switching current, which reduces any I<sup>2</sup>R losses in the load.



SLOS338D – SEPTEMBER 2000 – REVISED DECEMBER 2002



### **Figure 2. The TPA2001D1 Output Voltage and Current Waveforms Into an Inductive Load**

#### **efficiency: why you must use a filter with the traditional class-D modulation scheme**

The main reason that the traditional class-D amplifier needs an output filter is that the switching waveform results in maximum current flow. This causes more loss in the load, which causes lower efficiency. The ripple current is large for the traditional modulation scheme because the ripple current is proportional to voltage multiplied by the time at that voltage. The differential voltage swing is  $2 \times V_{DD}$  and the time at each voltage is half the period for the traditional modulation scheme. An ideal LC filter is needed to store the ripple current from each half cycle for the next half cycle, while any resistance causes power dissipation. The speaker is both resistive and reactive, whereas an LC filter is almost purely reactive.

The TPA2001D1 modulation scheme has very little loss in the load without a filter because the pulses are very short and the change in voltage is  $V_{DD}$  instead of  $2 \times V_{DD}$ . As the output power increases, the pulses widen making the ripple current larger. Ripple current could be filtered with an LC filter for increased efficiency, but for most applications the filter is not needed.

An LC filter with a cutoff frequency less than the class-D switching frequency allows the switching current to flow through the filter instead of the load. The filter has less resistance than the speaker that results in less power dissipated, which increases efficiency.



## **APPLICATION INFORMATION**

#### **effects of applying a square wave into a speaker**

Audio specialists advise not to apply a square wave to speakers. If the amplitude of the waveform is high enough and the frequency of the square wave is within the bandwidth of the speaker, the square wave could cause the voice coil to jump out of the air gap and/or scar the voice coil. A 250-kHz switching frequency, however, is not significant because the speaker cone movement is proportional to  $1/f<sup>2</sup>$  for frequencies beyond the audio band. Therefore, the amount of cone movement at the switching frequency is very small. However, damage could occur to the speaker if the voice coil is not designed to handle the additional power. To size the speaker for added power, the ripple current dissipated in the load needs to be calculated by subtracting the theoretical supplied power (P<sub>SUP THEORETICAL</sub>) from the actual supply power (P<sub>SUP</sub>) at maximum output power (P<sub>O</sub>). The switching power dissipated in the speaker is the inverse of the measured efficiency (η<sub>MEASURED</sub>) minus the theoretical efficiency (η<sub>THEORETICAL</sub>) all multiplied by P<sub>O</sub>.

$$
P_{SPKR} = P_{SUP} - P_{SUP} \cdot \text{THEORETICAL} \text{ (at max output power)}
$$
 (1)

 $P_{SPKR} = P_O(P_{SUP} / P_O - P_{SUP} / P_{H} = P_O(P_{H} / P_{I})$  (at max output power) (2)

 $P_{SPKR} = P_{O}(1/\eta_{MEASURED} - 1/\eta_{THEORETICAL})$  (at max output power) (3)

The maximum efficiency of the TPA2001D1 with an 8- $\Omega$  load is 85%. Using equation 3 with the efficiency at maximum power (78%), we see that there is an additional 106 mW dissipated in the speaker. The added power dissipated in the speaker is not an issue as long as it is taken into account when choosing the speaker.

#### **when to use an output filter**

Design the TPA2001D1 without the filter if the traces from amplifier to speaker are short. The TPA2001D1 passed FCC and CE radiated emissions with no shielding with speaker wires eight inches long or less. Notebook PCs and powered speakers where the speaker is in the same enclosure as the amplifier are good applications for class-D without a filter.

A ferrite bead filter can often be used if the design is failing radiated emissions without a filter, and the frequency sensitive circuit is greater than 1 MHz. This is good for circuits that just have to pass FCC and CE because FCC and CE only test radiated emissions greater than 30 MHz. If choosing a ferrite bead, choose one with high impedance at high frequencies, but very low impedance at low frequencies.

Use an output filter if there are low frequency (<1 MHz) EMI sensitive circuits and/or there are long leads from amplifier to speaker.

### **gain setting via GAIN0 and GAIN1 inputs**

The gain of the TPA2001D1 is set by two input terminals, GAIN0 and GAIN1.

The gains listed in Table 1 are realized by changing the taps on the input resistors inside the amplifier. This causes the input impedance, ZI, to be dependent on the gain setting. The actual gain settings are controlled by ratios of resistors, so the actual gain distribution from part-to-part is quite good. However, the input impedance may shift by 30% due to shifts in the actual resistance of the input resistors.

For design purposes, the input network (discussed in the next section) should be designed assuming an input impedance of 20 kΩ, which is the absolute minimum input impedance of the TPA2001D1. At the higher gain settings, the input impedance could increase as high as 115 kΩ.



## **APPLICATION INFORMATION**



#### **Table 1. Gain Settings**

### **input resistance**

Each gain setting is achieved by varying the input resistance of the amplifier, which can range from its smallest value to over six times that value. As a result, if a single capacitor is used in the input high-pass filter, the –3 dB or cutoff frequency also changes by over six times.



The –3 dB frequency can be calculated using equation 4.

$$
f_{\rm c} = \frac{1}{2\pi Z_{\rm l}C_{\rm i}}\tag{4}
$$

### **input capacitor, Ci**

In the typical application an input capacitor  $(C_i)$  is required to allow the amplifier to bias the input signal to the proper dc level for optimum operation. In this case, C<sub>i</sub> and the input impedance of the amplifier (Z<sub>I</sub>) form a high-pass filter with the corner frequency determined in equation 5.





## **APPLICATION INFORMATION**

#### **input capacitor, Ci (continued)**

The value of C<sub>i</sub> is important, as it directly affects the bass (low frequency) performance of the circuit. Consider the example where Z<sub>I</sub> is 20 kΩ and the specification calls for a flat bass response down to 80 Hz. Equation 5 is reconfigured as equation 6.

$$
C_i = \frac{1}{2\pi Z_i f_c} \tag{6}
$$

In this example,  ${\sf C}_{\sf i}$  is 0.1  $\mu$ F, so one would likely choose a value in the range of 0.1  $\mu$ F to 1  $\mu$ F. If the gain is known and will be constant, use Z<sub>I</sub> from Table 1 to calculate C<sub>i</sub>. A further consideration for this capacitor is the leakage path from the input source through the input network (C<sub>i</sub>) and the feedback network to the load. This leakage current creates a dc offset voltage at the input to the amplifier that reduces useful headroom, especially in high gain applications. For this reason a low-leakage tantalum or ceramic capacitor is the best choice. When polarized capacitors are used, the positive side of the capacitor should face the amplifier input in most applications as the dc level there is held at  $V_{DD}/2$ , which is likely higher than the source dc level. Note that it is important to confirm the capacitor polarity in the application.

 ${\sf C}_{\sf i}$  must be 10 times smaller than the bypass capacitor to reduce clicking and popping noise from power on/off and entering and leaving shutdown. After sizing C<sub>i</sub> for a given cutoff frequency, size the bypass capacitor to 10 times that of the input capacitor.

$$
C_i \leq C_{\rm BYP} / 10 \tag{7}
$$

#### power supply decoupling, C<sub>S</sub>

The TPA2001D1 is a high-performance CMOS audio amplifier that requires adequate power supply decoupling to ensure the output total harmonic distortion (THD) is as low as possible. Power supply decoupling also prevents oscillations for long lead lengths between the amplifier and the speaker. The optimum decoupling is achieved by using two capacitors of different types that target different types of noise on the power supply leads. For higher frequency transients, spikes, or digital hash on the line, a good low equivalent-series-resistance (ESR) ceramic capacitor, typically 0.1  $\mu$ F placed as close as possible to the device V<sub>DD</sub> lead works best. For filtering lower-frequency noise signals, a larger aluminum electrolytic capacitor of 10  $\mu$ F or greater placed near the audio power amplifier is recommended.

#### **midrail bypass capacitor, C(BYP)**

The midrail bypass capacitor  $(C_{(BYP)})$  is the most critical capacitor and serves several important functions. During start-up or recovery from shutdown mode, C<sub>(BYP)</sub> determines the rate at which the amplifier starts up. The second function is to reduce noise produced by the power supply caused by coupling into the output drive signal. This noise is from the midrail generation circuit internal to the amplifier, which appears as degraded PSRR and THD+N.

Bypass capacitor (C<sub>(BYP)</sub>) values of 0.47-µF to 1-µF ceramic or tantalum low-ESR capacitors are recommended for the best THD and noise performance.

Increasing the bypass capacitor reduces clicking and popping noise from power on/off and entering and leaving shutdown. To have minimal pop,  $\mathsf{C_{(BYP)}}$  should be 10 times larger than  $\mathsf{C_{i}.}$ 

$$
C_{\text{(BYP)}} \ge 10 \times C_i \tag{8}
$$



SLOS338D – SEPTEMBER 2000 – REVISED DECEMBER 2002

## **APPLICATION INFORMATION**

#### **differential input**

The differential input stage of the amplifier cancels any noise that appears on both input lines of the channel. To use the TPA2001D1 EVM with a differential source, connect the positive lead of the audio source to the INP input and the negative lead from the audio source to the INN input. To use the TPA2001D1 with a single-ended source, ac ground the INN input through a capacitor and apply the audio single to the input. In a single-ended input application, the INN input should be ac-grounded at the audio source instead of at the device input for best noise performance.

#### **shutdown modes**

The TPA2001D1 employs a shutdown mode of operation designed to reduce supply current ( $I_{DD}$ ) to the absolute minimum level during periods of nonuse for battery-power conservation. The SHUTDOWN input terminal should be held high during normal operation when the amplifier is in use. Pulling SHUTDOWN low causes the outputs to mute and the amplifier to enter a low-current state,  $I_{DD(SD)} = 1 \mu A$ . SHUTDOWN should never be left unconnected because amplifier operation would be unpredictable.

### **using low-ESR capacitors**

Low-ESR capacitors are recommended throughout this application section. A real (as opposed to ideal) capacitor can be modeled simply as a resistor in series with an ideal capacitor. The voltage drop across this resistor minimizes the beneficial effects of the capacitor in the circuit. The lower the equivalent value of this resistance the more the real capacitor behaves like an ideal capacitor.

#### **evaluation circuit**



NOTE: R1, R2, and R3 are used in the EVM but are not required for normal applications.



## **APPLICATION INFORMATION**

### **Table 2. TPA2001D1 Evaluation Bill of Materials**



† These components are used in the EVM, but they are not required for normal applications.





## **PACKAGING INFORMATION**



**(1)** The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

**LIFEBUY:** TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

**NRND:** Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

**PREVIEW:** Device has been announced but is not in production. Samples may or may not be available.

**OBSOLETE:** TI has discontinued the production of the device.

<sup>(2)</sup> RoHS: TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures. "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".

RoHS Exempt: TI defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption.

Green: TI defines "Green" to mean the content of Chlorine (CI) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of <=1000ppm threshold. Antimony trioxide based flame retardants must also meet the <=1000ppm threshold requirement.

**(3)** MSL, Peak Temp. - The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

**(4)** There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.

**(5)** Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.

<sup>(6)</sup> Lead/Ball Finish - Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead/Ball Finish values may wrap to two lines if the finish value exceeds the maximum column width.

**Important Information and Disclaimer:**The information provided on this page represents TI's knowledge and belief as of the date that it is provided. TI bases its knowledge and belief on information provided by third parties, and makes no representation or warranty as to the accuracy of such information. Efforts are underway to better integrate information from third parties. TI has taken and continues to take reasonable steps to provide representative and accurate information but may not have conducted destructive testing or chemical analysis on incoming materials and chemicals. TI and TI suppliers consider certain information to be proprietary, and thus CAS numbers and other limited information may not be available for release.



# **PACKAGE OPTION ADDENDUM**

www.ti.com 24-Aug-2018

In no event shall TI's liability arising out of such information exceed the total purchase price of the TI part(s) at issue in this document sold by TI to Customer on an annual basis.

# **PACKAGE MATERIALS INFORMATION**

## **TAPE AND REEL INFORMATION**

### **REEL DIMENSIONS**

**TEXAS**<br>INSTRUMENTS





TAPE AND REEL INFORMATION

#### **TAPE DIMENSIONS**









TEXAS<br>INSTRUMENTS

# **PACKAGE MATERIALS INFORMATION**

www.ti.com 14-Jul-2012



\*All dimensions are nominal





# **PACKAGE OUTLINE**

# **PW0016A TSSOP - 1.2 mm max height**

SMALL OUTLINE PACKAGE



NOTES:

- 1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
- 2. This drawing is subject to change without notice.
- 3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.15 mm per side.
- 4. This dimension does not include interlead flash. Interlead flash shall not exceed 0.25 mm per side.
- 5. Reference JEDEC registration MO-153.



# **EXAMPLE BOARD LAYOUT**

# **PW0016A TSSOP - 1.2 mm max height**

SMALL OUTLINE PACKAGE



NOTES: (continued)

6. Publication IPC-7351 may have alternate designs.

7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.



# **EXAMPLE STENCIL DESIGN**

# **PW0016A TSSOP - 1.2 mm max height**

SMALL OUTLINE PACKAGE



NOTES: (continued)

- 8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
- 9. Board assembly site may have different recommendations for stencil design.



#### **IMPORTANT NOTICE AND DISCLAIMER**

TI PROVIDES TECHNICAL AND RELIABILITY DATA (INCLUDING DATASHEETS), DESIGN RESOURCES (INCLUDING REFERENCE DESIGNS), APPLICATION OR OTHER DESIGN ADVICE, WEB TOOLS, SAFETY INFORMATION, AND OTHER RESOURCES "AS IS" AND WITH ALL FAULTS, AND DISCLAIMS ALL WARRANTIES, EXPRESS AND IMPLIED, INCLUDING WITHOUT LIMITATION ANY IMPLIED WARRANTIES OF MERCHANTABILITY, FITNESS FOR A PARTICULAR PURPOSE OR NON-INFRINGEMENT OF THIRD PARTY INTELLECTUAL PROPERTY RIGHTS.

These resources are intended for skilled developers designing with TI products. You are solely responsible for (1) selecting the appropriate TI products for your application, (2) designing, validating and testing your application, and (3) ensuring your application meets applicable standards, and any other safety, security, or other requirements. These resources are subject to change without notice. TI grants you permission to use these resources only for development of an application that uses the TI products described in the resource. Other reproduction and display of these resources is prohibited. No license is granted to any other TI intellectual property right or to any third party intellectual property right. TI disclaims responsibility for, and you will fully indemnify TI and its representatives against, any claims, damages, costs, losses, and liabilities arising out of your use of these resources.

TI's products are provided subject to TI's Terms of Sale ([www.ti.com/legal/termsofsale.html\)](http://www.ti.com/legal/termsofsale.html) or other applicable terms available either on [ti.com](http://www.ti.com) or provided in conjunction with such TI products. TI's provision of these resources does not expand or otherwise alter TI's applicable warranties or warranty disclaimers for TI products.

> Mailing Address: Texas Instruments, Post Office Box 655303, Dallas, Texas 75265 Copyright © 2019, Texas Instruments Incorporated